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FILE COVERS 1907 - 26 Oct 2004 VOL 141 ISS 18
FILE LAST UPDATED: 25 Oct 2004 (20041025/ED)

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=> s (multiphoton or multiple photon)
      13402 MULTIPHOTON
      335822 MULTIPLE
      116796 PHOTON
      955 MULTIPLE PHOTON
          (MULTIPLE (W) PHOTON)
L1      13877 (MULTIPHOTON OR MULTIPLE PHOTON)

=> s l1 and refractive
      67040 REFRACTIVE
L2      81 L1 AND REFRACTIVE

=> s l1 and refract?
      208965 REFRACT?
L3      109 L1 AND REFRACT?

=> s l3 and visible
      287748 VISIBLE
L4      11 L3 AND VISIBLE

=> d all 1-11

L4      ANSWER 1 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN      2003:138225 CAPLUS
DN      138:408809
ED      Entered STN: 24 Feb 2003
TI      Multiphoton absorption of solutions of polydiacetylene
          polyDCHD-HS measured using ps Z-scan at 1064 and 1500 nm
AU      Giorgetti, Emilia; Toci, Guido; Vannini, Matteo; Giannanco, Francesco
CS      Istituto di Fisica Applicata "Nello Carrara" -CNR, Florence, 50127, Italy
SO      Optics Communications (2003), 217(1-6), 431-439
        CODEN: OPCOB8; ISSN: 0030-4018
PB      Elsevier Science B.V.
DT      Journal
```

LA English
CC 73-10 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
AB The nonlinear absorption of benzene and toluene solns. of polydiacetylene polyDCHD-HS was measured at $\lambda=1064$ and 1500 nm by using Z-scan and picosecond pulses with a trimmed Airy beam configuration. In the data anal., the authors took into account both the saturation of the open aperture Z-scan traces occurring for high values of nonlinear absorption and the possible occurrence of cross-talk effects between nonlinear refraction and multiphoton absorption. The polymer exhibits three-photon absorption at both 1064 and 1500 nm. The mol. three-photon absorption coefficient at 1064 nm was $\sigma_3=1.8 + 10^{-38}$ cm⁶/W² and $\sigma_3=2.3 + 10^{-38}$ cm⁶/W² in toluene and benzene, resp., while at 1500 nm it was $\sigma_3=1.5 + 10^{-39}$ cm⁶/W² in toluene. On this basis, the optical limiting behavior of polyDCHD-HS in the near IR range is also shown.
ST multiphoton absorption polydiacetylene Z scan optical limiting
IT Multiphoton absorption
Nonlinear optical absorption
Optical limiting
UV and visible spectra
(multiphoton absorption of solns. of polydiacetylene polyDCHD-HS measured using ps Z-scan at 1064 and 1500 nm)
IT Polydiacetylenes
RL: PRP (Properties)
(multiphoton absorption of solns. of polydiacetylene polyDCHD-HS measured using ps Z-scan at 1064 and 1500 nm)
IT 71-43-2, Benzene, uses 108-88-3, Toluene, uses
RL: NUU (Other use, unclassified); USES (Uses)
(multiphoton absorption of solns. of polydiacetylene polyDCHD-HS in benzene or toluene solution)
IT 175736-86-4
RL: PRP (Properties)
(multiphoton absorption of solns. of polydiacetylene polyDCHD-HS measured using ps Z-scan at 1064 and 1500 nm)
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L4 ANSWER 2 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2003:81478 CAPLUS
DN 138:328164
ED Entered STN: 03 Feb 2003
TI Optical properties of femtosecond irradiated photo-thermo-
refractive glass
AU Juodkazis, S.
CS Institute of Materials Science and Applied Research, Vilnius University,
Vilnius, 2040, Lithuania
SO Lithuanian Journal of Physics (2002), 42(2), 119-126
CODEN: LJPIAD
PB Lithuanian Physical Society
DT Journal
LA English
CC 73-2 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
Section cross-reference(s): 57
AB Photomodification of optical properties (absorption and **refraction**
) of photo-thermo-**refractive** (PTR) glass by its exposure to
femtosecond (fs) irradiation is reported. Irradiation was made by fs pulses at
the fundamental wavelength of 775 nm and at the 2nd harmonic of 388 nm.
Exposure was controlled by focusing and timing of 1 kHz laser radiation.
Both wavelengths are out of the absorption band of Ce³⁺ centered at 304 nm
with the bandwidth of .apprx.40 nm. Just this absorption band is
responsible for initiation of photomodification, which finally forms a
ceramic material at the exposed regions after thermal treatment, typically
at 520° for 2 h. Fs illumination can be successfully implemented
to record **refractive** index changes comparable to those recorded
by continuous-wave exposures to a 325. nm line of He-Cd laser. After the
thermal development the **refractive** index changes up to 10-4 were
obtained. The mechanism of fs photomodification is discussed in terms of
white light continuum (supercontinuum (SC)) generation and
multiphoton absorption. The model of a silicate glass coloration
via the two-photon absorption of fs SC is proposed. It is based on the
comparison of coloration of PTR glass with that of alkali- and
boro-silicate glasses under fs pulses.
ST optical property irradiated photo thermo **refractive** glass; white
light continuum glass laser irradn
IT Defects in solids
(effect of formation of; optical properties of femtosecond irradiated
photo-thermo-**refractive** glass)
IT Heat treatment
(effect of; optical properties of femtosecond irradiated photo-thermo-
refractive glass)
IT Optical absorption
Optical **refraction**
(induced; optical properties of femtosecond irradiated photo-thermo-
refractive glass)
IT Laser radiation
(irradiation effect; optical properties of femtosecond irradiated
photo-thermo-**refractive** glass)

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IT Optical properties
 Refractive index
 Two-photon absorption
 UV and **visible** spectra
 (optical properties of femtosecond irradiated photo-thermo-
 refractive glass)
IT Silicate glasses
RL: PRP (Properties)
 (optical properties of femtosecond irradiated photo-thermo-
 refractive glass)
IT Glass, properties
RL: PRP (Properties)
 (photo-thermo-**refractive**; optical properties of femtosecond
 irradiated photo-thermo-**refractive** glass)
IT 7681-49-4, Sodium fluoride, occurrence
RL: OCU (Occurrence, unclassified); OCCU (Occurrence)
 (effect of formation of; optical properties of femtosecond irradiated
 photo-thermo-**refractive** glass)
IT 1305-78-8, Calcium oxide, occurrence 1306-38-3, Cerium dioxide,
 occurrence 1313-59-3, Sodium oxide, occurrence 1314-13-2, Zinc oxide,
 occurrence 1344-28-1, Aluminum oxide, occurrence 7631-86-9, Silicon
 oxide, occurrence 7758-02-3, Potassium bromide, occurrence 20667-12-3,
 Silver oxide
RL: OCU (Occurrence, unclassified); OCCU (Occurrence)
 (glass containing; optical properties of femtosecond irradiated
 photo-thermo-**refractive** glass)

RE.CNT 33 THERE ARE 33 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

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 V4347, P343
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L4 ANSWER 3 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2002:160423 CAPLUS
DN 136:207766
ED Entered STN: 05 Mar 2002
TI Method and apparatus for laser marking and marked optical materials
IN Hayashi, Kenichi
PA Sumitomo Heavy Industries, Ltd., Japan
SO Jpn. Kokai Tokkyo Koho, 5 pp.
CODEN: JKXXAF
DT Patent
LA Japanese
IC ICM B23K026-00
ICS B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18;
G02B005-32
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reproductive Processes)
Section cross-reference(s): 73
FAN.CNT 1

| PATENT NO. | KIND | DATE | APPLICATION NO. | DATE |
|---------------------|-------|----------|-----------------|----------|
| ----- | ----- | ----- | ----- | ----- |
| PI JP 2002066769 | A2 | 20020305 | JP 2000-257182 | 20000828 |
| JP 3522670 | B2 | 20040426 | | |
| PRAI JP 2000-257182 | | 20000828 | | |

CLASS

| PATENT NO. | CLASS | PATENT FAMILY CLASSIFICATION CODES |
|---------------|-------|---|
| ----- | ----- | ----- |
| JP 2002066769 | ICM | B23K026-00 |
| | ICS | B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18; G02B005-32 |

AB The apparatus comprises a laser beam source, a hologram plate, an optical scanning system for deflection of the diffraction beams, an optical focusing system for convergence of the diffraction beams, and a stage for placing the marking substrate at the positions where the diffraction beams are converged. Marking of materials by forming multiple nos. of points having varied refractive index caused by **multiphoton** absorption is claimed. Optical materials marked with patterns that diffract **visible** light and method for marking are also claimed. Easily **visible** markings are formed without damaging the marked materials.

ST laser marking app optical material; **multiphoton** absorption laser marking; grating laser induced marking holog

IT Holographic diffraction gratings
Laser induced grating
(apparatus for highly **visible** laser marking of materials without their damaging)

IT Marking
(laser; apparatus for highly **visible** laser marking of materials without their damaging)

IT **Multiphoton** absorption
(marking by; apparatus for highly **visible** laser marking of materials without their damaging)

IT Glass, processes
RL: PEP (Physical, engineering or chemical process); PYP (Physical process); PROC (Process)
(marking of; apparatus for highly **visible** laser marking of materials without their damaging)

L4 ANSWER 4 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
 AN 2001:734065 CAPLUS
 DN 135:296267
 ED Entered STN: 09 Oct 2001
 TI Method of making **visible** marks in a transparent material by laser beam radiation, marking apparatus, and transparent optical member marked by the method
 IN Hayashi, Kenichi; Ito, Kazuyoshi
 PA Sumitomo Heavy Industries, Ltd., Japan
 SO Jpn. Kokai Tokkyo Koho, 9 pp.
 CODEN: JKXXAF
 DT Patent
 LA Japanese
 IC ICM B23K026-00
 ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18
 CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)
 Section cross-reference(s): 73

FAN.CNT 1

| | PATENT NO. | KIND | DATE | APPLICATION NO. | DATE |
|------|----------------|------|----------|-----------------|----------|
| PI | JP 2001276985 | A2 | 20011009 | JP 2000-258854 | 20000829 |
| | JP 3522671 | B2 | 20040426 | | |
| | US 2002041323 | A1 | 20020411 | US 2001-940604 | |
| | US 6621041 | B2 | 20030916 | | |
| PRAI | JP 2000-19062 | A | 20000127 | | |
| | JP 2000-258854 | A | 20000829 | | |

CLASS

| PATENT NO. | CLASS | PATENT FAMILY CLASSIFICATION CODES |
|---------------|-------|--|
| JP 2001276985 | ICM | B23K026-00 |
| | | ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18 |
| US 2002041323 | ECLA | G02B005/18M2 |

AB In marking a transparent material, a laser beam of wavelength capable of transmitting the material is focused on inner part of the transparent material to allow **multiphoton** absorption and cause n changes, and the focal point of the laser beam is so moved as to form a diffraction pattern which diffracts a **visible** ray. An optically marking apparatus is equipped with a stage for loading the material, a light source emitting the laser beam, an optical system for focusing the laser beam, and a means of moving the focal point to form the diffraction grating. A transparent optical member, marked by the method, has the diffraction pattern inside. Alternatively, a method of marking marks in a material comprises the following steps; (1) irradiating the material with a pulsed laser beam by changing NA of an object lens and energy intensity per one pulse (EI) to form optically modified region, (2) determining a function of NA, EI, and length of modified region (LE), (3) determining NA and EI from the required LE by using the function, and (4) irradiating the laser beam to form the modified region. The marking method does not cause damage or drop in strength of the material, and the formed mark can be easily recognized without using a readout apparatus

ST transparent material marking laser radiation n change; diffraction grating formation laser radiation transparent material marking; **multiphoton** absorption laser induced diffraction grating marking; glass marking laser induced diffraction grating

IT Refractive index
 (changes; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical

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member)

IT **Multiphoton absorption**

(laser radiation; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT **Laser induced grating**

Marking

Transparent materials

(making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT **Laser radiation**

(pulsed; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT **Glass substrates**

(transparent; making **visible** marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

L4 ANSWER 5 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN

AN 2001:262366 CAPLUS

DN 135:38692

ED Entered STN: 13 Apr 2001

TI Polydiacetylene PTS: a molecular quantum wire with exceptional optical properties

AU Trevino-Palacios, Carlos G.; Stegeman, George; Liu, Mingguo; Yoshino, Fumiyo; Poliakov, Sergey; Friedrich, Lars; Flom, Steven R.; Lindle, J. R.; Bartoli, F. J.

CS School of Optics and CREOL, University of Central Florida, Orlando, FL, USA

SO NATO Science Series, II: Mathematics, Physics and Chemistry (2000), 6(Frontiers of Nano-Optoelectronic Systems), 209-226
CODEN: NSSICD

PB Kluwer Academic Publishers

DT Journal

LA English

CC 73-10 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)

AB Section cross-reference(s): 36

The conjugated polymer 2,4-hexadiyne-1,6-diobis(p-toluenesulfonate) or PTS is a classical example of a 1-dimensional quantum wire. The π -electrons can move more or less freely in 1 dimension. There are large repercussions to this effect in the photonics field, including photocond., and the linear and nonlinear optical response. Growing techniques of crystals with high optical quality as well as measurements on a variety of nonlinear optical effects of PTS are reported in this chapter. These include measurements on the large magnitude of the exciton absorption line, the well-defined vibrational side bands at room temperature, massive 2 and 4 photon absorption coeffs., very large Raman gain coeffs., minimal excited state absorption and a large nonlinear **refractive index**.

ST polydiacetylene PTS mol quantum wire exceptional optical property

IT Quantum wire devices

(mol.; hexadiynediobis(toluenesulfonate) with exceptional optical properties)

IT IR spectra

(near-IR, transient; of hexadiynediobis(toluenesulfonate) mol. quantum wire)

IT **Refractive index**

(nonlinear; of hexadiynediobis(toluenesulfonate) mol. quantum wire)

STN search for 10/622488

IT Absorptivity
Degenerate four wave mixing
Excited state absorption
Exciton
Multiphoton absorption
Nonlinear optical properties
Optical properties
Photoconductivity
Raman spectra
UV and visible spectra

(of hexadiyneolbis(toluenesulfonate) mol. quantum wire)
IT 32535-60-7, Poly(2,4-Hexadiyne-1,6-diol bis(p-toluenesulfonate))
51853-07-7, Poly(2,4-Hexadiyne-1,6-diol bis(p-toluenesulfonate)), SRU
RL: DEV (Device component use); PRP (Properties); USES (Uses)
(mol. quantum wire with exceptional optical properties)

RE.CNT 26 THERE ARE 26 CITED REFERENCES AVAILABLE FOR THIS RECORD
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L4 ANSWER 6 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2000:482928 CAPLUS

DN 133:244952

ED Entered STN: 18 Jul 2000

TI Wavelength dependence of photoreduction of Ag⁺ ions in glasses through the multiphoton process

AU Kondo, Yuki; Inouye, Hideyuki; Fujiwara, Seiji; Suzuki, Toshio; Mitsuyu, Tsuneo; Yoko, Toshinobu; Hirao, Kazuyuki

CS Hirao Active Glass Project, Exploratory Research for Advanced Technolog, Super-Lab 2F6, Japan Science and Technology Corporation, Seika, Kyoto, 619-0237, Japan

SO Journal of Applied Physics (2000), 88(3), 1244-1250

CODEN: JAPIAU; ISSN: 0021-8979
PB American Institute of Physics
DT Journal
LA English
CC 74-1 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)
Section cross-reference(s): 57, 73
AB We have investigated the wavelength dependence of the photoredn. of Ag⁺ ions in glass irradiated by visible femtosecond pulses. These pulses, issued at wavelengths ranging from 400 to 800 nm, were nonresonant with the glass absorption. In this article, a relationship between threshold powers, wavelengths, and linear and nonlinear refractive indexes is described. The nonlinear refractive index of Ag⁺-doped glass was measured by an optical Kerr shutter method. The wavelength dependence of threshold powers of the photoredn. is explained by considering linear and nonlinear refractive indexes. The mechanism of the photoredn. is also discussed.
ST photoredn silver glass nonlinear refraction
IT Aluminosilicate glasses
RL: PEP (Physical, engineering or chemical process); RCT (Reactant); TEM (Technical or engineered material use); PROC (Process); RACT (Reactant or reagent); USES (Uses)
(sodium; wavelength dependence of photoredn. of Ag⁺ ions in glasses through the multiphoton process)
IT Nonlinear optical refraction
Photon
Reduction, photochemical
Refractive index
(wavelength dependence of photoredn. of Ag⁺ ions in glasses through the multiphoton process)
IT 1314-13-2, Zinc oxide, uses 1314-60-9, Antimony pentoxide 7681-49-4, Sodium fluoride, uses 18282-10-5, Tin dioxide
RL: TEM (Technical or engineered material use); USES (Uses)
(glass; wavelength dependence of photoredn. of Ag⁺ ions in glasses through the multiphoton process)
IT 14701-21-4, Silver 1+, reactions
RL: PEP (Physical, engineering or chemical process); RCT (Reactant); TEM (Technical or engineered material use); PROC (Process); RACT (Reactant or reagent); USES (Uses)
(wavelength dependence of photoredn. of Ag⁺ ions in glasses through the multiphoton process)
RE.CNT 29 THERE ARE 29 CITED REFERENCES AVAILABLE FOR THIS RECORD
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L4 ANSWER 7 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1999:535149 CAPLUS
DN 131:264484
ED Entered STN: 26 Aug 1999
TI Enhanced photosensitivity in germanosilicate fibers exposed to CO₂ laser
radiation
AU Brambilla, G.; Pruneri, V.; Reekie, L.; Payne, D. N.
CS Optoelectronics Research Centre, Southampton University, Southampton,
SO17-1BJ, UK
SO Optics Letters (1999), 24(15), 1023-1025
CODEN: OPLEDP; ISSN: 0146-9592
PB Optical Society of America
DT Journal
LA English
CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
Section cross-reference(s): 57, 74
AB The authors report a novel method to increase the UV photosensitivity of
GeO₂:SiO₂ optical fibers based on exposure to CO₂ laser irradiation before
grating writing. Fibers treated with a CO₂ laser can produce gratings
with refractive-index modulation 2 times greater and a Bragg
wavelength that can be 2 nm longer than those of untreated fibers. Expts.
on GeO₂:SiO₂ preform samples treated with a CO₂ laser in a way similar to
the fibers showed a marked increase of the 242-nm absorption band, which
is associated with an increase of Ge O-deficient centers and is believed to
be responsible for the higher photorefractive response.
ST photosensitivity germanosilicate optical fiber carbon dioxide laser
radiation; diffraction grating germanosilicate optical fiber
photosensitivity laser irradn; multiphoton absorption
germanosilicate optical fiber photosensitivity laser irradn;
photorefraction germanosilicate optical fiber photosensitivity laser
irradn; near IR reflection germanosilicate optical fiber diffraction
grating photosensitivity; UV optical fiber preform photosensitivity laser
irradn
IT Diffraction gratings
Laser radiation
 Multiphoton absorption
 Optical fibers
 Photorefractive effect
 UV and visible spectra
 (enhanced photosensitivity in germanosilicate optical fibers exposed to
 CO₂ laser radiation with diffraction gratings)
IT IR reflectance spectra
 (near-IR; enhanced photosensitivity in germanosilicate optical fibers
 exposed to CO₂ laser radiation with diffraction gratings)
IT Germanosilicate glasses
RL: DEV (Device component use); PEP (Physical, engineering or chemical

STN search for 10/622488

process); PRP (Properties); PROC (Process); USES (Uses)
(optical fibers; enhanced photosensitivity in germanosilicate optical
fibers exposed to CO₂ laser radiation with diffraction gratings)
IT Glass fibers, properties
RL: DEV (Device component use); PEP (Physical, engineering or chemical
process); PRP (Properties); PROC (Process); USES (Uses)
(optical germanosilicate; enhanced photosensitivity in germanosilicate
optical fibers exposed to CO₂ laser radiation with diffraction
gratings)
IT Defects in solids
(oxygen-deficient; enhanced photosensitivity in germanosilicate optical
fibers exposed to CO₂ laser radiation with diffraction gratings)
IT 1310-53-8, Germania, properties 60676-86-0, Vitreous silica
RL: DEV (Device component use); PEP (Physical, engineering or chemical
process); PRP (Properties); PROC (Process); USES (Uses)
(enhanced photosensitivity in germanosilicate optical fibers exposed to
CO₂ laser radiation with diffraction gratings)
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L4 ANSWER 8 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1998:54471 CAPLUS
DN 128:198067
ED Entered STN: 30 Jan 1998
TI Linear optical properties and **multiphoton** absorption of alkali
halides calculated from first principles
AU Li, Jun; Duan, Chun-gang; Gu, Zong-quan; Wang, Ding-sheng
CS Center for Condensed Matter Physics, Institute of Physics, Laboratory for
Surface Physics, Academia Sinica, Beijing, 100080, Peop. Rep. China
SO Physical Review B: Condensed Matter and Materials Physics (1998), 57(4),
2222-2228
CODEN: PRBMDO; ISSN: 0163-1829
PB American Physical Society
DT Journal
LA English
CC 73-4 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
Section cross-reference(s): 76
AB This paper reports the calcn. of linear optical properties and
multiphoton absorption (MPA) coeffs. of alkali halides MX (M = Na,
K; X = F, Cl, Br, I) using the 1st-principles linearized APW band method
and the time-dependent perturbation theory. The calcns. are in good
agreement with available exptl. data. For linear optical properties, the
trend of the static dielec. consts. with respect to the halides is
attributed to the variation of the optical oscillator strength arising
from the electronic transitions of the valence p bands. For MPA coeffs.
(1/2E_g, E_g) show an increase of MPA coeffs. with respect to the atomic number
of

the halogen elements. The polarization dependence of the MPA coeffs. is also given, which promotes further expts.

ST alkali halide optical property **multiphoton** absorption; sodium halide optical property **multiphoton** absorption; potassium halide optical property **multiphoton** absorption; **refractive index** alkali halide; oscillator strength alkali halide; dielec const alkali halide; band structure alkali halide; two photon absorption alkali halide; UV **visible** alkali halide two photon

IT Band structure
Dielectric constant
 Multiphoton absorption
Oscillator strength
 Refractive index
Two-photon absorption
 (linear optical properties and **multiphoton** absorption of alkali halides calculated from first principles)

IT Alkali metal halides, properties
RL: PEP (Physical, engineering or chemical process); PRP (Properties);
PROC (Process)
 (linear optical properties and **multiphoton** absorption of alkali halides calculated from first principles)

IT UV and **visible** spectra
 (two-photon; linear optical properties and **multiphoton** absorption of alkali halides calculated from first principles)

IT 7447-40-7, Potassium chloride (KCl), properties 7647-14-5, Sodium chloride (NaCl), properties 7647-15-6, Sodium bromide (NaBr), properties 7681-11-0, Potassium iodide (KI), properties 7681-49-4, Sodium fluoride (NaF), properties 7681-82-5, Sodium iodide (NaI), properties 7758-02-3, Potassium bromide (KBr), properties 7789-23-3, Potassium fluoride (KF)
RL: PEP (Physical, engineering or chemical process); PRP (Properties);
PROC (Process)
 (linear optical properties and **multiphoton** absorption of alkali halides calculated from first principles)

RE.CNT 31 THERE ARE 31 CITED REFERENCES AVAILABLE FOR THIS RECORD

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L4 ANSWER 9 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1996:708975 CAPLUS
DN 126:39300
ED Entered STN: 29 Nov 1996
TI Writing waveguides in glass with a femtosecond laser
AU Davis, K. M.; Miura, K.; Sugimoto, N.; Hirao, K.
CS Exploratory Research Advanced Technology, Research Development Corporation
Japan, Kyoto, G06, Japan
SO Optics Letters (1996), 21(21), 1729-1731
CODEN: OPLEDP; ISSN: 0146-9592
PB Optical Society of America
DT Journal
LA English
CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
AB With the goal of being able to create optical devices for the
telecommunications industry, the effects of 810-nm, fs laser radiation on
various glasses were studied. By focusing the laser beam through a
microscope objective, the transparent, but **visible**,
round-elliptical damage lines were written inside high-SiO₂, borate, soda
lime silicate, and fluorozirconate (ZBLAN) bulk glasses..
Microellipsometer measurements of the damaged region in the pure and
Ge-doped SiO₂ glasses showed a 0.01-0.035 **refractive** index
increase, depending on the radiation dose. The formation of several
defects, including Si E' or Ge E' centers, nonbridging O hole centers, and
peroxy radicals, was detected. Probably **multiphoton**
interactions occur in the glasses, and it may be possible to write
3-dimensional optical circuits in bulk glasses with such a focused laser
beam technique.
ST waveguide glass writing femtosecond laser
IT Glass, properties
RL: PRP (Properties)
 (fluorozirconate; writing waveguides with fs laser in)
IT Lenses
 (microscope; writing waveguides in glass with fs laser using)
IT Peroxides, formation (nonpreparative)
RL: FMU (Formation, unclassified); FORM (Formation, nonpreparative)
 (radicals; in waveguides written in glass with fs laser)
IT Glass, properties
RL: PRP (Properties)
 (silica; writing waveguides with fs laser in)
IT Communication
 (telecommunication; writing waveguides in glass with fs laser for)
IT Waveguides
 (writing in glass with fs laser)
IT Laser radiation
 (writing waveguides in glass with fs)
IT Optical instruments
 (writing waveguides in glass with fs laser for)
IT Borate glasses
Soda-lime glasses

STN search for 10/622488

RL: PRP (Properties)
(writing waveguides with fs laser in)
IT 7440-56-4, Germanium, uses
RL: MOA (Modifier or additive use); USES (Uses)
(writing waveguides with fs laser in silica glass doped with)

L4 ANSWER 10 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1993:112173 CAPLUS
DN 118:112173
ED Entered STN: 19 Mar 1993
TI The lowest excited singlet state of 1,4-diphenyl-1,3-cyclopentadiene
AU Ci, Xiaopei; Kohler, Bryan E.; Moller, Soren; Shaler, Thomas A.; Yee, W.
Atom
CS Dep. Chem., Univ. California, Riverside, CA, 92521-0403, USA
SO Journal of Physical Chemistry (1993), 97(8), 1515-20
CODEN: JPCHAX; ISSN: 0022-3654
DT Journal
LA English
CC 73-4 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
AB The authors report a high-resolution excitation spectrum for 1,4-diphenyl-1,3-cyclopentadiene cooled in a supersonic expansion. The spectrum, which was obtained using 2-color resonance-enhanced multiphoton ionization techniques, has an origin at 27,008 cm⁻¹. The dependence of absorption and fluorescence spectra on solvent and the vapor phase absorption spectrum shows that the lowest energy excited singlet state in the isolated mol. is the 2A state. The order of excited singlet states reverses in the condensed phase: the 1B state is S1 in solvents with refractive indexes of 1.25-1.56. The lifetime of the 2A state in the isolated mol. could not be accurately determined, though an upper bound of 10 ns could be placed on it. These results give insight into the effect that an s-cis conformation in a polyene has on its electronic structure.
ST singlet state lowest excited diphenylcyclopentadiene; phenylcyclopentadiene spectra lowest excited singlet state; cyclopentadiene diphenyl spectra lowest excited singlet; electronic spectra diphenylcyclopentadiene; multiphoton ionization spectra diphenylcyclopentadiene; vibrational spectra diphenylcyclopentadiene
IT Fluorescence
Infrared spectra
Molecular vibration
Ultraviolet and visible spectra
(of diphenylcyclopentadiene)
IT Electronic structure
(of diphenylcyclopentadiene, conformation effects on)
IT Conformation and Conformers
(of diphenylcyclopentadiene, electronic structure dependence on)
IT Solvent effect
(on electronic spectra of diphenylcyclopentadiene, by organic solvents)
IT Energy level transition
(electronic, radiative, of diphenylcyclopentadiene, fluorescence lifetimes in relation to)
IT Ionization, photo-
(resonant multiphoton, two-color, of diphenylcyclopentadiene)
IT Energy level
(singlet, lowest, of diphenylcyclopentadiene)
IT 4982-34-7, 1,4-Diphenyl-1,3-cyclopentadiene
RL: PRP (Properties)
(singlet lowest excited state and electronic and vibrational spectra of, conformation in relation to)

STN search for 10/622488

L4 ANSWER 11 OF 11 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1991:617994 CAPLUS
DN 115:217994
ED Entered STN: 15 Nov 1991
TI **Refraction** of molecular gases in the IR laser field
AU Burtsev, A. P.; Korotkov, S. A.; Popov, A. G.; Tret'yakov, P. Yu.;
Khikmatov, H. G.
CS USSR
SO Molekulyarnaya Spektroskopiya (1990), 8, 61-76
CODEN: MLKSA9
DT Journal
LA Russian
CC 73-10 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
AB Mach-Zehnder interferometric study of the kinetics of **refractive**
index variation Δn during a **multiphoton** absorption of a
pulsed IR radiation showed the effect of vibrational excitation on the average
mol. polarizability of gaseous SF₆, CF₃I, (CF₃)₃Cl, OsO₄, and CF₂Cl₂. In
the **visible** spectral region, the initial sharp increase in
 Δn was followed by an oscillatory decay due to a superposition of
the vibrational-translational relaxation and an acoustic-wave-induced d.
wave in the gas.
ST polarizability mol IR pulse excitation gas; **refractive** index gas
IR pulse excitation; sulfur fluoride polarizability IR pulse excitation;
fluoromethyl iodide polarizability IR pulse excitation; methyl fluoro
iodide polarizability IR excitation; butyl fluoro iodide polarizability IR
excitation
IT Laser radiation, chemical and physical effects
(heating of mol. gases by pulsed, **refractive** index variation
kinetics in relation to)
IT **Refractive** index and Optical **refraction**
(kinetics of variation of, of mol. gases under pulsed IR laser heating)
IT Polarizability
(of mol. gases under pulsed IR heating)
IT Energy level excitation
(vibrational, of pulsed, of mol. gases, mol. polarizability in relation
to)
IT 75-71-8, Dichlorodifluoromethane 2314-97-8, Trifluoroiodomethane
2551-62-4, Sulfur hexafluoride 4459-18-1, Tristrifluoromethyl iodomethane
20816-12-0
RL: PRP (Properties)
(**refractive** index variation kinetics of gases, under pulsed
IR laser heating)

=> s (multiphoton or multiple photon) and refract?

13402 MULTIPHOTON
335822 MULTIPLE
116796 PHOTON
955 MULTIPLE PHOTON
(MULTIPLE (W) PHOTON)

208965 REFRACT?

L5 109 (MULTIPHOTON OR MULTIPLE PHOTON) AND REFRACT?

=> s (multiphoton or multiple photon) and diffract?

13402 MULTIPHOTON
335822 MULTIPLE
116796 PHOTON
955 MULTIPLE PHOTON

STN search for 10/622488

(MULTIPLE (W) PHOTON)
418560 DIFFRACT?

L6 106 (MULTIPHOTON OR MULTIPLE PHOTON) AND DIFFRACT?
=> s 15 and 16
L7 9 L5 AND L6

=> d all 1-9

L7 ANSWER 1 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2003:741193 CAPLUS
DN 139:388367
ED Entered STN: 22 Sep 2003
TI Holographic volume gratings in bulk Perylene orange-doped hybrid
inorganic-organic materials by the coherent field of a femtosecond laser
AU Qian, Guodong; Guo, Jiayu; Wang, Minquan; Si, Jinhai; Qiu, Jianrong;
Hirao, Kazuyuki
CS State Key Lab of Silicon Materials, Department of Materials Science and
Engineering, Zhejiang University, Hangzhou, 310035, Peop. Rep. China
SO Applied Physics Letters (2003), 83(12), 2327-2329
CODEN: APPLAB; ISSN: 0003-6951
PB American Institute of Physics
DT Journal
LA English
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reproductive Processes)
Section cross-reference(s): 73
AB Holog. volume gratings with high first-order Bragg **diffraction**
efficiency (greater than 35%) were fabricated in bulk laser-dye-doped
hybrid inorg.-organic materials by the coherent fields of a femtosecond
laser. Observations of optical microscopy show that **refractive**
-index-modulated volume gratings were realized inside the sample through
multiphoton absorption process. The isomerization and alignment
of the laser dye mols. are responsible for the grating formation. The
authors suggest that the materials co-doped with laser dye and azo-dye and
with photoinduced gratings inside are promising materials for making the
distributed feedback tunable lasers.
ST holog grating Perylene orange doped hybrid inorg org material
IT Lasers
(distributed feedback, tunable; holog. volume gratings fabricated in bulk
of sol-gel derived hybrid inorg.-organic materials doped with laser dye in
relation to)
IT Holographic **diffraction** gratings
Hybrid organic-inorganic materials
Multiphoton absorption
(holog. volume gratings fabricated in bulk of sol-gel derived hybrid
inorg.-organic materials doped with laser dye)
IT Holography
(holog. volume gratings fabricated in bulk of sol-gel derived hybrid
inorg.-organic materials doped with laser dye in relation to)
IT Molecular orientation
(photoinduced; holog. volume gratings fabricated in bulk of sol-gel
derived hybrid inorg.-organic materials doped with laser dye)
IT Isomerization
(photoisomerization; holog. volume gratings fabricated in bulk of sol-gel
derived hybrid inorg.-organic materials doped with laser dye)
IT 159777-98-7, Perylene orange
RL: MOA (Modifier or additive use); PEP (Physical, engineering or chemical
process); PYP (Physical process); PROC (Process); USES (Uses)
(holog. volume gratings fabricated in bulk of sol-gel derived hybrid

inorg.-organic materials doped with laser dye)
IT 78-08-0, Vinyltriethoxysilane
RL: RCT (Reactant); RACT (Reactant or reagent)
(precursor; preparation of sol-gel derived hybrid inorg.-organic materials)
RE.CNT 21 THERE ARE 21 CITED REFERENCES AVAILABLE FOR THIS RECORD
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L7 ANSWER 2 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2003:92005 CAPLUS
DN 138:346381
ED Entered STN: 06 Feb 2003
TI Photofabrication of periodic microstructures in azo dye-doped polymers by interference of laser beams
AU Si, J. H.; Qiu, J. R.; Hirao, K.
CS Photon Craft Project, JST, ICORP, 1-7 Hikaridai, Seika-cho, Kyoto, 619-0237, Japan
SO Applied Physics B: Lasers and Optics (2002), 75(8), 847-851
CODEN: APBOEM; ISSN: 0946-2171
PB Springer-Verlag
DT Journal
LA English
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)
AB Volume holog. gratings and two-dimensional periodic microstructures in azo dye-doped poly(Me methacrylate) were fabricated, resp., by interference of two coherent beams of a femtosecond laser and by interference of three coherent beams of a nanosecond laser. The dependence of the first-order Bragg diffraction efficiency and the photoinduced refractive-index modulation of the gratings on the intensity of the writing light was investigated. The measurements of the absorption spectra before and after irradiation with the writing light suggest that the photoinduced gratings were refractive-index-modulated gratings, which arose from a photoinduced decomposition reaction of the azo dye mols. through multiphoton absorption. In the expts. involving the interference of three beams, the period of the two-dimensional periodic microstructures was changed by adjusting the angle between the three writing beams.
ST photofabrication periodic microstructure azo dye doped polymer; vol holog grating recording azo dye doped PMMA

STN search for 10/622488

IT Laser ablation
Microstructure
 (fabrication of two-dimensional periodic microstructures in azo dye-doped PMMA by interference of three coherent beams of nanosecond laser beams)
IT Holographic diffraction gratings
Holography
 Multiphoton absorption
 (fabrication of volume holog. gratings in azo dye-doped PMMA by interference of femtosecond laser beams via multiphoton -induced photodecompn. of dopant dye)
IT Photolysis
 (multiphoton; fabrication of volume holog. gratings in azo dye-doped PMMA by interference of femtosecond laser beams via multiphoton-induced photodecompn. of dopant dye)
IT 9011-14-7, PMMA
RL: PEP (Physical, engineering or chemical process); PYP (Physical process); PROC (Process)
 (fabrication of volume holog. gratings and two-dimensional periodic microstructures in azo dye-doped PMMA)
IT 144748-38-9
RL: RCT (Reactant); RACT (Reactant or reagent)
 (fabrication of volume holog. gratings in azo dye-doped PMMA by interference of femtosecond laser beams via multiphoton -induced photodecompn. of dopant dye)

RE.CNT 19 THERE ARE 19 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

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L7 ANSWER 3 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2002:438354 CAPLUS
DN 137:176350
ED Entered STN: 11 Jun 2002
TI In situ observation of dynamics of plasma formation and refractive index modification in silica glasses excited by a femtosecond laser
AU Cho, Sung-Hak; Kumagai, Hiroshi; Midorikawa, Katsumi
CS Laser Technology Laboratory, The Institute of Physical and Chemical Research (RIKEN), Wako, Saitama, 351-0198, Japan
SO Optics Communications (2002), 207(1-6), 243-253
 CODEN: OPCOB8; ISSN: 0030-4018
PB Elsevier Science B.V.
DT Journal

LA English
CC 73-2 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
Section cross-reference(s): 57, 76, 77
AB Time-resolved dynamics of plasma formation and bulk **refractive** index modification in SiO₂ glasses excited by a tightly focused femtosecond (110 fs) Ti:sapphire laser ($\lambda_p=800$ nm) was 1st observed in situ. The newly proposed pump-probe measurement with perpendicularly linear polarized beams was used to study the dynamic of both plasma formation and induced **refractive** index bulk modification. The energy variation of transmitted probe beam with time delay, which propagates through the induced plasma is measured. At the pre-breakdown domain, the lifetime of induced plasma formation is .apprx.15 ps and structural transition time for forming the **refractive** index change is .apprx.10 ps. At the breakdown domain, however, the lifetime of induced plasma formation is .apprx.35 ps and structural transition time for forming the optical damage is .apprx.35 ps. The process of **refractive** index bulk modification is significantly different from that of optical damage. According to the ESR spectroscopic measurement, the defect concentration of SiE' center increased significantly in the modified region in related to that of the region without modification. From the **diffraction** efficiency of Kogelnik's coupled mode theory, the maximum value of **refractive** index change (Δn) is 1.1 + 10-2. By the scanning of SiO₂ glass on the optical X-Y-Z stages, the fabrication of the internal grating with **refractive** index modification was demonstrated in SiO₂ glass using tightly focused femtosecond laser. The exptl. results will be helpful to understand the phys. mechanism of the plasma and structural transformation induced by tightly focused high-intensity femtosecond lasers in transparent materials.
ST silica glass laser plasma dynamics **refractive** index ESR photorefraction; self focusing silica glass laser irradn; **multiphoton** ionization silica glass laser irradn; paramagnetic defect silica glass laser irradn ESR; **diffraction** optical silica glass laser irradn photorefraction
IT Defects in solids
ESR (electron spin resonance)
Laser induced plasma
Optical damage threshold
Optical **diffraction**
Paramagnetic centers
Photorefractive effect
 Refractive index
Structural phase transition
 (in situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by femtosecond laser)
IT Photoionization
 (**multiphoton**; in situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by femtosecond laser)
IT Optical properties
 (self-focusing; in situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by femtosecond laser)
IT 60676-86-0, Vitreous silica
RL: PRP (Properties)
 (in situ observation of dynamics of plasma formation and **refractive** index modification in silica glasses excited by femtosecond laser)
RE.CNT 29 THERE ARE 29 CITED REFERENCES AVAILABLE FOR THIS RECORD

STN search for 10/622488

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L7 ANSWER 4 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2002:160423 CAPLUS
DN 136:207766
ED Entered STN: 05 Mar 2002
TI Method and apparatus for laser marking and marked optical materials
IN Hayashi, Kenichi
PA Sumitomo Heavy Industries, Ltd., Japan
SO Jpn. Kokai Tokkyo Koho, 5 pp.
CODEN: JKXXAF
DT Patent
LA Japanese
IC ICM B23K026-00
 ICS B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18;
 G02B005-32
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
 Reprographic Processes)
 Section cross-reference(s): 73
FAN.CNT 1

| | PATENT NO. | KIND | DATE | APPLICATION NO. | DATE |
|------|----------------|------|----------|-----------------|----------|
| PI | JP 2002066769 | A2 | 20020305 | JP 2000-257182 | 20000828 |
| | JP 3522670 | B2 | 20040426 | | |
| PRAI | JP 2000-257182 | | 20000828 | | |

CLASS

| PATENT NO. | CLASS | PATENT FAMILY CLASSIFICATION CODES |
|---------------|-------|---|
| JP 2002066769 | ICM | B23K026-00 |
| | ICS | B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18; G02B005-32 |

STN search for 10/622488

AB The apparatus comprises a laser beam source, a hologram plate, an optical scanning system for deflection of the **diffraction** beams, an optical focusing system for convergence of the **diffraction** beams, and a stage for placing the marking substrate at the positions where the **diffraction** beams are converged. Marking of materials by forming multiple nos. of points having varied **refractive** index caused by **multiphoton** absorption is claimed. Optical materials marked with patterns that **diffract** visible light and method for marking are also claimed. Easily visible markings are formed without damaging the marked materials.
ST laser marking app optical material; **multiphoton** absorption laser marking; grating laser induced marking holog
IT Holographic **diffraction** gratings
Laser induced grating
(apparatus for highly visible laser marking of materials without their damaging)
IT Marking
(laser; apparatus for highly visible laser marking of materials without their damaging)
IT **Multiphoton** absorption
(marking by; apparatus for highly visible laser marking of materials without their damaging)
IT Glass, processes
RL: PEP (Physical, engineering or chemical process); PYP (Physical process); PROC (Process)
(marking of; apparatus for highly visible laser marking of materials without their damaging)

L7 ANSWER 5 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2001:907640 CAPLUS
DN 136:207283
ED Entered STN: 17 Dec 2001
TI Interplay between self-focusing and high-order **multiphoton** absorption
AU Polyakov, Sergey; Yoshino, Fumiyo; Stegeman, George
CS School of Optics and Center for Research and Education in Optics and Lasers, University of Central Florida, Orlando, FL, 32816, USA
SO Journal of the Optical Society of America B: Optical Physics (2001), 18(12), 1891-1895
CODEN: JOBPDE; ISSN: 0740-3224
PB Optical Society of America
DT Journal
LA English
CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
AB The authors study the distortion of optical beams that is due to the combined effects of strong self-focusing and 3- and 4-photon absorption, a situation that exists, for example, in the polydiacetylene bis-paratoluene sulfonate (PTS). The characteristic nonlinear distances were defined for each process. Theor. anal. of the beam propagation leads to 2 distinct limits, 1 limit dominated by self-focusing and the other by higher-order absorption. Propagation was studied anal. and numerically for continuous-wave and pulsed beams in these 2 limits and for cases in which both nonlinear effects are important. Beam distortion caused by **multiphoton** absorption and **refraction** leads to situations in which **diffraction** plays an important role, even for input beams whose **diffraction** length is much larger than the sample length. For the typical intensities used in Z-scan measurements, nonlinear processes and **diffraction** contribute simultaneously to beam distortion and must be taken into account.

STN search for10/622488

ST interplay focusing multiphoton absorption
IT Optical absorption
(interplay between self-focusing and high-order multiphoton absorption)

IT 32535-60-7
RL: PRP (Properties)
(interplay between self-focusing and high-order multiphoton absorption)

RE.CNT 18 THERE ARE 18 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

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L7 ANSWER 6 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN

AN 2001:734065 CAPLUS

DN 135:296267

ED Entered STN: 09 Oct 2001

TI Method of making visible marks in a transparent material by laser beam radiation, marking apparatus, and transparent optical member marked by the method

IN Hayashi, Kenichi; Ito, Kazuyoshi

PA Sumitomo Heavy Industries, Ltd., Japan

SO Jpn. Kokai Tokkyo Koho, 9 pp.

CODEN: JKXXAF

DT Patent

LA Japanese

IC ICM B23K026-00

ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18

CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)
Section cross-reference(s): 73

FAN.CNT 1

| | PATENT NO. | KIND | DATE | APPLICATION NO. | DATE |
|------|----------------|------|----------|-----------------|----------|
| PI | JP 2001276985 | A2 | 20011009 | JP 2000-258854 | 20000829 |
| | JP 3522671 | B2 | 20040426 | | |
| | US 2002041323 | A1 | 20020411 | US 2001-940604 | 20010829 |
| | US 6621041 | B2 | 20030916 | | |
| PRAI | JP 2000-19062 | A | 20000127 | | |
| | JP 2000-258854 | A | 20000829 | | |

CLASS

PATENT NO. CLASS PATENT FAMILY CLASSIFICATION CODES

STN search for 10/622488

JP 2001276985 ICM B23K026-00
ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00;
G02B005-18

US 2002041323 ECLA G02B005/18M2

AB In marking a transparent material, a laser beam of wavelength capable of transmitting the material is focused on inner part of the transparent material to allow **multiphoton** absorption and cause n changes, and the focal point of the laser beam is so moved as to form a **diffraction** pattern which **diffRACTS** a visible ray. An optically marking apparatus is equipped with a stage for loading the material, a light source emitting the laser beam, an optical system for focusing the laser beam, and a means of moving the focal point to form the **diffraction** grating. A transparent optical member, marked by the method, has the **diffraction** pattern inside. Alternatively, a method of marking marks in a material comprises the following steps; (1) irradiating the material with a pulsed laser beam by changing NA of an object lens and energy intensity per one pulse (EI) to form optically modified region, (2) determining a function of NA, EI, and length of modified region (LE), (3) determining NA and EI from the required LE by using the function, and (4) irradiating the laser beam to form the modified region. The marking method does not cause damage or drop in strength of the material, and the formed mark can be easily recognized without using a readout apparatus

ST transparent material marking laser radiation n change; **diffraction** grating formation laser radiation transparent material marking; **multiphoton** absorption laser induced **diffraction** grating marking; glass marking laser induced **diffraction** grating

IT **Refractive** index
(changes; making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT **Multiphoton** absorption
(laser radiation; making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT Laser induced grating
Marking
Transparent materials
(making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT Laser radiation
(pulsed; making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

IT Glass substrates
(transparent; making visible marks in transparent material by laser beam radiation, marking apparatus, and mark-formed transparent optical member)

L7 ANSWER 7 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2001:243986 CAPLUS
DN 135:26571
ED Entered STN: 06 Apr 2001
TI Arbitrary-lattice photonic crystals created by **multiphoton** micro-fabrication
AU Sun, Hong-Bo; Xu, Ying; Juodkazis, Saulius; Sun, Kai; Watanabe, Mitsuru; Matsuo, Shigeki; Misawa, Hiroaki; Nishii, Junji
CS Satellite Venture Business Laboratory, The University of Tokushima, Tokushima, 770-8506, Japan
SO Optics Letters (2001), 26(6), 325-327
CODEN: OPLEDP; ISSN: 0146-9592
PB Optical Society of America

STN search for 10/622488

DT Journal
LA English
CC 73-10 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
AB The authors used voxels of an intensely modified **refractive index** generated by **multiphoton absorption** at the focus of femtosecond laser pulses in Ge-doped SiO₂ as photonic atoms to build photonic lattices. The voxels were spatially organized in the same way as atoms arrayed in actual crystals, and a Bragg-like **diffraction** from the photonic atoms was evidenced by a photonic bandgap (PBG) effect. Post-fabrication annealing is essential for reducing random scattering and therefore enhancing PBG. This technique has an intrinsic capability of individually addressing single atoms. Therefore the introduction of defect structures was much facilitated, making the technique quite appealing for photonic research and applications.
ST photonic crystal **multiphoton** microfabrication
IT Annealing
Band gap
 Multiphoton absorption
 Optical **diffraction**
 Optical **refraction**
 Photonic crystals
 Photonics
 Solid state lasers
 (arbitrary-lattice photonic crystals created by **multiphoton** micro-fabrication)
IT 7631-86-9, Silica, uses
RL: DEV (Device component use); MOA (Modifier or additive use); USES (Uses)
 (arbitrary-lattice photonic crystals created by **multiphoton** micro-fabrication)
IT 1310-53-8, Germanium oxide (GeO₂), uses 7440-56-4, Germanium, uses 13463-67-7, Titania, uses
RL: MOA (Modifier or additive use); USES (Uses)
 (arbitrary-lattice photonic crystals created by **multiphoton** micro-fabrication)
RE.CNT 17 THERE ARE 17 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE
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L7 ANSWER 8 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1999:535149 CAPLUS
DN 131:264484
ED Entered STN: 26 Aug 1999

TI Enhanced photosensitivity in germanosilicate fibers exposed to CO₂ laser radiation
AU Brambilla, G.; Pruner, V.; Reekie, L.; Payne, D. N.
CS Optoelectronics Research Centre, Southampton University, Southampton, SO17-1BJ, UK
SO Optics Letters (1999), 24(15), 1023-1025
CODEN: OPLEDP; ISSN: 0146-9592
PB Optical Society of America
DT Journal
LA English
CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related Properties)
Section cross-reference(s): 57, 74
AB The authors report a novel method to increase the UV photosensitivity of GeO₂:SiO₂ optical fibers based on exposure to CO₂ laser irradiation before grating writing. Fibers treated with a CO₂ laser can produce gratings with refractive-index modulation 2 times greater and a Bragg wavelength that can be 2 nm longer than those of untreated fibers. Expts. on GeO₂:SiO₂ preform samples treated with a CO₂ laser in a way similar to the fibers showed a marked increase of the 242-nm absorption band, which is associated with an increase of Ge O-deficient centers and is believed to be responsible for the higher photorefractive response.
ST photosensitivity germanosilicate optical fiber carbon dioxide laser radiation; **diffraction** grating germanosilicate optical fiber photosensitivity laser irradn; **multiphoton** absorption germanosilicate optical fiber photosensitivity laser irradn; photorefraction germanosilicate optical fiber photosensitivity laser irradn; near IR reflection germanosilicate optical fiber **diffraction** grating photosensitivity; UV optical fiber preform photosensitivity laser irradn
IT **Diffraction** gratings
Laser radiation
 Multiphoton absorption
Optical fibers
Photorefractive effect
UV and visible spectra
 (enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction** gratings)
IT IR reflectance spectra
 (near-IR; enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction** gratings)
IT Germanosilicate glasses
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
 (optical fibers; enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction** gratings)
IT Glass fibers, properties
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
 (optical germanosilicate; enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction** gratings)
IT Defects in solids
 (oxygen-deficient; enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction** gratings)
IT 1310-53-8, Germania, properties 60676-86-0, Vitreous silica
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)

STN search for 10/622488

(enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction** gratings)

RE.CNT 12 THERE ARE 12 CITED REFERENCES AVAILABLE FOR THIS RECORD
RE

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L7 ANSWER 9 OF 9 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1974:483774 CAPLUS
DN 81:83774
ED Entered STN: 12 May 1984
TI **Multiphoton** photorefractive processes for optical storage in lithium niobate(V)
AU Von der Linde, D.; Glass, A. M.; Rodgers, K. F.
CS Bell Lab., Murray Hill, NJ, USA
SO Applied Physics Letters (1974), 25(3), 155-7
CODEN: APPLAB; ISSN: 0003-6951
DT Journal
LA English
CC 73-2 (Spectra by Absorption, Emission, Reflection, or Magnetic Resonance, and Other Optical Properties)
AB Permanent reversible changes of the n of pure and doped LiNbO₃ were obtained by **multiphoton** absorption. Greatly increased sensitivity over the linear process enables holograms to be recorded even in high-purity LiNbO₃, with a **diffraction** efficiency of 25% with less than 0.4 J/cm². These holograms can be read nondestructively, eliminating the need for fixing processes while the versatility of optical erasure is maintained.
ST **multiphoton** lithium niobate **refraction**; hologram lithium niobate **multiphoton**
IT Photon
 (absorption of many, lithium niobate **refractive** index change in)
IT Holography
 (lithium niobate **multiphoton** photorefractive process in)
IT **Refractive** index and **Refraction**
 (permanent reversible changes of, by **multiphoton** absorption)
IT 12031-63-9
RL: USES (Uses)
 (**multiphoton** photorefractive change of, in holog.)

=> d his

(FILE 'HOME' ENTERED AT 10:55:31 ON 26 OCT 2004)

FILE 'CAPLUS' ENTERED AT 10:55:46 ON 26 OCT 2004
L1 13877 S (MULTIPHOTON OR MULTIPLE PHOTON)
L2 81 S L1 AND REFRACTIVE
L3 109 S L1 AND REFRACT?

STN search for 10/622488

L4 11 S L3 AND VISIBLE
L5 109 S (MULTIPHOTON OR MULTIPLE PHOTON) AND REFRACT?
L6 106 S (MULTIPHOTON OR MULTIPLE PHOTON) AND DIFFRACT?
L7 9 S L5 AND L6

=> s 17 and visibl?
289564 VISIBL?
L8 3 L7 AND VISIBL?

=> d all 1-3

L8 ANSWER 1 OF 3 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2002:160423 CAPLUS
DN 136:207766
ED Entered STN: 05 Mar 2002
TI Method and apparatus for laser marking and marked optical materials
IN Hayashi, Kenichi
PA Sumitomo Heavy Industries, Ltd., Japan
SO Jpn. Kokai Tokkyo Koho, 5 pp.
CODEN: JKXXAF
DT Patent
LA Japanese
IC ICM B23K026-00
ICS B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18;
G02B005-32
CC 74-8 (Radiation Chemistry, Photochemistry, and Photographic and Other
Reproductive Processes)
Section cross-reference(s): 73

FAN.CNT 1

| | PATENT NO. | KIND | DATE | APPLICATION NO. | DATE |
|------|----------------|------|----------|-----------------|----------|
| PI | JP 2002066769 | A2 | 20020305 | JP 2000-257182 | 20000828 |
| | JP 3522670 | B2 | 20040426 | | |
| PRAI | JP 2000-257182 | | 20000828 | | |

CLASS

| | PATENT NO. | CLASS | PATENT FAMILY CLASSIFICATION CODES |
|--|---------------|-------|---|
| | JP 2002066769 | ICM | B23K026-00 |
| | | ICS | B23K026-06; B23K026-08; B41J002-44; C03C023-00; G02B005-18; G02B005-32 |

AB The apparatus comprises a laser beam source, a hologram plate, an optical scanning system for deflection of the **diffraction** beams, an optical focusing system for convergence of the **diffraction** beams, and a stage for placing the marking substrate at the positions where the **diffraction** beams are converged. Marking of materials by forming multiple nos. of points having varied **refractive** index caused by **multiphoton** absorption is claimed. Optical materials marked with patterns that **diffract visible** light and method for marking are also claimed. Easily **visible** markings are formed without damaging the marked materials.

ST laser marking app optical material; **multiphoton** absorption laser marking; grating laser induced marking holog

IT Holographic **diffraction** gratings
Laser induced grating
(apparatus for highly **visible** laser marking of materials without their damaging)

IT Marking
(laser; apparatus for highly **visible** laser marking of materials without their damaging)

IT **Multiphoton** absorption

STN search for 10/622488

(marking by; apparatus for highly **visible** laser marking of materials without their damaging)

IT Glass, processes

RL: PEP (Physical, engineering or chemical process); PYP (Physical process); PROC (Process)

(marking of; apparatus for highly **visible** laser marking of materials without their damaging)

L8 ANSWER 2 OF 3 CAPLUS COPYRIGHT 2004 ACS on STN
AN 2001:734065 CAPLUS

DN 135:296267

ED Entered STN: 09 Oct 2001

TI Method of making **visible** marks in a transparent material by laser beam radiation, marking apparatus, and transparent optical member marked by the method

IN Hayashi, Kenichi; Ito, Kazuyoshi

PA Sumitomo Heavy Industries, Ltd., Japan

SO Jpn. Kokai Tokkyo Koho, 9 pp.

CODEN: JKXXAF

DT Patent

LA Japanese

IC ICM B23K026-00

ICS B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18

CC 74-13 (Radiation Chemistry, Photochemistry, and Photographic and Other Reprographic Processes)

Section cross-reference(s): 73

FAN.CNT 1

| | PATENT NO. | KIND | DATE | APPLICATION NO. | DATE |
|------|----------------|------|----------|-----------------|----------|
| PI | JP 2001276985 | A2 | 20011009 | JP 2000-258854 | 20000829 |
| | JP 3522671 | B2 | 20040426 | | |
| | US 2002041323 | A1 | 20020411 | US 2001-940604 | 20010829 |
| | US 6621041 | B2 | 20030916 | | |
| PRAI | JP 2000-19062 | A | 20000127 | | |
| | JP 2000-258854 | A | 20000829 | | |

CLASS

| PATENT NO. | CLASS | PATENT FAMILY CLASSIFICATION CODES |
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| JP 2001276985 | ICM | B23K026-00 |
| | ICS | B23K026-00; B23K026-04; B23K026-08; C03C023-00; G02B005-18 |
| US 2002041323 | ECLA | G02B005/18M2 |

AB In marking a transparent material, a laser beam of wavelength capable of transmitting the material is focused on inner part of the transparent material to allow **multiphoton** absorption and cause n changes, and the focal point of the laser beam is so moved as to form a **diffraction** pattern which **diffRACTS** a **visible** ray. An optically marking apparatus is equipped with a stage for loading the material, a light source emitting the laser beam, an optical system for focusing the laser beam, and a means of moving the focal point to form the **diffraction** grating. A transparent optical member, marked by the method, has the **diffraction** pattern inside. Alternatively, a method of marking marks in a material comprises the following steps; (1) irradiating the material with a pulsed laser beam by changing NA of an object lens and energy intensity per one pulse (EI) to form optically modified region, (2) determining a function of NA, EI, and length of modified region (LE), (3) determining NA and EI from the required LE by using the function, and (4) irradiating the laser beam to form the modified region. The marking method does not cause damage or drop in strength of the material, and the formed mark can be easily recognized without using a

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ST readout apparatus
transparent material marking laser radiation n change; **diffraction**
grating formation laser radiation transparent material marking;
multiphoton absorption laser induced **diffraction** grating
marking; glass marking laser induced **diffraction** grating

IT **Refractive** index
(changes; making **visible** marks in transparent material by
laser beam radiation, marking apparatus, and mark-formed transparent optical
member)

IT **Multiphoton** absorption
(laser radiation; making **visible** marks in transparent
material by laser beam radiation, marking apparatus, and mark-formed
transparent optical member)

IT Laser induced grating
Marking
Transparent materials
(making **visible** marks in transparent material by laser beam
radiation, marking apparatus, and mark-formed transparent optical member)

IT Laser radiation
(pulsed; making **visible** marks in transparent material by
laser beam radiation, marking apparatus, and mark-formed transparent optical
member)

IT Glass substrates
(transparent; making **visible** marks in transparent material by
laser beam radiation, marking apparatus, and mark-formed transparent optical
member)

L8 ANSWER 3 OF 3 CAPLUS COPYRIGHT 2004 ACS on STN
AN 1999:535149 CAPLUS
DN 131:264484
ED Entered STN: 26 Aug 1999
TI Enhanced photosensitivity in germanosilicate fibers exposed to CO₂ laser
radiation
AU Brambilla, G.; Pruneri, V.; Reekie, L.; Payne, D. N.
CS Optoelectronics Research Centre, Southampton University, Southampton,
SO17-1BJ, UK
SO Optics Letters (1999), 24(15), 1023-1025
CODEN: OPLEDP; ISSN: 0146-9592
PB Optical Society of America
DT Journal
LA English
CC 73-11 (Optical, Electron, and Mass Spectroscopy and Other Related
Properties)
Section cross-reference(s): 57, 74
AB The authors report a novel method to increase the UV photosensitivity of
GeO₂:SiO₂ optical fibers based on exposure to CO₂ laser irradiation before
grating writing. Fibers treated with a CO₂ laser can produce gratings
with **refractive-index** modulation 2 times greater and a Bragg
wavelength that can be 2 nm longer than those of untreated fibers. Expts.
on GeO₂:SiO₂ preform samples treated with a CO₂ laser in a way similar to
the fibers showed a marked increase of the 242-nm absorption band, which
is associated with an increase of Ge O-deficient centers and is believed to
be responsible for the higher photorefractive response.

ST photosensitivity germanosilicate optical fiber carbon dioxide laser
radiation; **diffraction** grating germanosilicate optical fiber
photosensitivity laser irradn; **multiphoton** absorption
germanosilicate optical fiber photosensitivity laser irradn;
photorefraction germanosilicate optical fiber photosensitivity laser
irradn; near IR reflection germanosilicate optical fiber
diffraction grating photosensitivity; UV optical fiber preform

STN search for10/622488

photosensitivity laser irradn
IT Diffraction gratings
Laser radiation
Multiphoton absorption
Optical fibers
Photorefractive effect
UV and visible spectra
(enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction gratings**)
IT IR reflectance spectra
(near-IR; enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction gratings**)
IT Germanosilicate glasses
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
(optical fibers; enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction gratings**)
IT Glass fibers, properties
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
(optical germanosilicate; enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction gratings**)
IT Defects in solids
(oxygen-deficient; enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction gratings**)
IT 1310-53-8, Germania, properties 60676-86-0, Vitreous silica
RL: DEV (Device component use); PEP (Physical, engineering or chemical process); PRP (Properties); PROC (Process); USES (Uses)
(enhanced photosensitivity in germanosilicate optical fibers exposed to CO₂ laser radiation with **diffraction gratings**)
RE.CNT 12 THERE ARE 12 CITED REFERENCES AVAILABLE FOR THIS RECORD
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